

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10574455	NIV ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
BENJAMIN P LEE	3641	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
89	40.03	10/16/2008	LEE
89	37.17	10/16/2008	LEE
89	41.02	10/16/2008	LEE
89	41.05	10/16/2008	LEE
89	36.08	10/16/2008	LEE
89	37.01	5/22/2009	LEE
89	37.02	5/22/2009	LEE
89	37.03	5/22/2009	LEE

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text search	10/16/2008	LEE
inventor search	5/22/2009	LEE

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
89	40.03	5/22/2009	LEE
89	37.17	5/22/2009	LEE
89	41.02	5/22/2009	LEE
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